

**GSFC · 2015** 

# Bayesian-based Simulation Model Validation for Spacecraft Thermal Systems

Dr. Kevin Stout MIT
Conor McMenamin MIT
Dr. Rebecca Masterson MIT

Prof. Karen Willcox MIT Prof. Youssef Marzouk MIT



#### **Presentation Overview**

#### Introduction

- Background and Motivation
- Literature Review
- Research Goal

#### Bayesian-based Model Validation (BMV) Methodology

- Methodology Overview
- REXIS Solar X-ray Monitor (SXM) Case Study

#### Conclusion

- Primary Contributions
- Recommendations for Future Work
- Acknowledgements



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#### **Motivation**

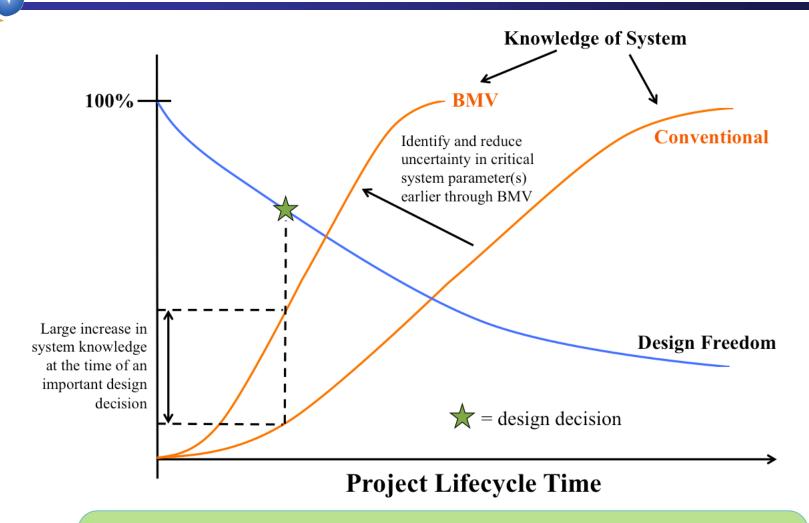
How effective are current model validation practices?

- Literature review of flight temperatures vs. model predictions
- Thermal systems are successful but:
  - Overdesign w.r.t. stacked worst case scenarios
  - Occasional model inaccuracies



Improve thermal model validation process to reduce *form*-related and *process*-related costs long term

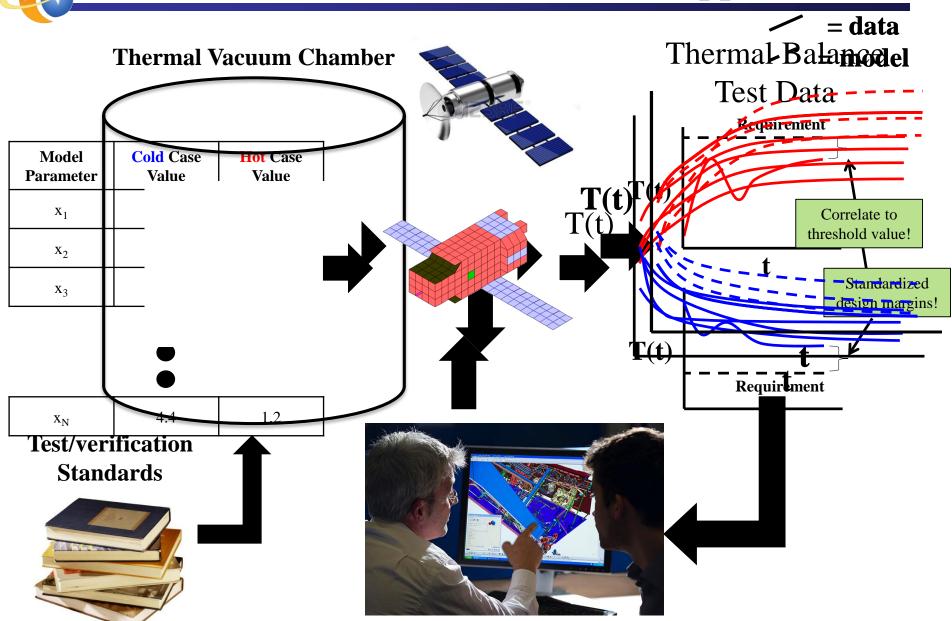
#### **Bayesian-based Model Validation (BMV) Motivation**



Potential to increase knowledge of the system earlier in the project lifecycle when important design decisions are made



#### **A Conventional Model Validation Approach**





#### Literature Review Summary and Research Goal

Summary of Literature Review					
Area State of the Art		Thermal Convention			
Uncertainty Propagation (UP)	Probabilistic uncertainty characterization; UA/GSA [13,14]	Convex uncertainty characterization; margin "downstream" of model [15-17]			
Design of Experiments (DOE)	Optimal (Bayesian) Experimental Design [20,21]	Classical DOE [15-19]			
Model Calibration	Bayesian [24-27] (K-O approach [22,23])	Manual model correlation [1]			

#### Research Gap

In practice, the state of the art methods are used rarely and in limited capacity

No existing framework to combine state of the art methods for thermal systems

#### **Research Goal**

Improve the thermal model validation process by developing a tailored methodology that combines the state of the art validation methods of Uncertainty Quantification (UQ) and Design of Experiments (DOE).



#### **Presentation Overview**

#### Introduction

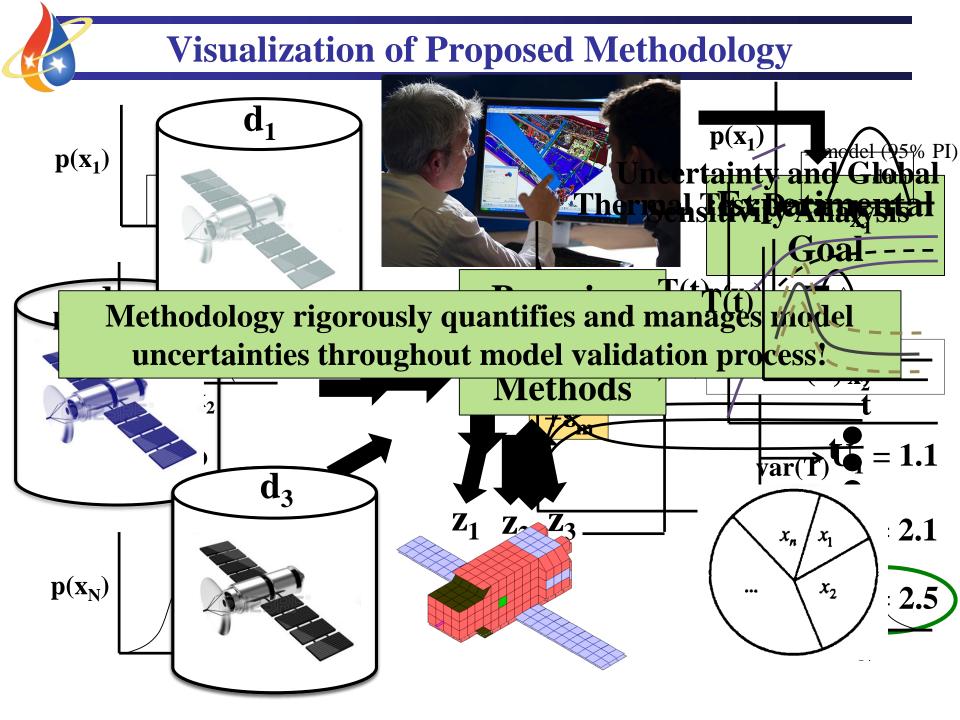
- Background and Motivation
- Literature Review
- Research Goal and Thesis Objectives

#### Bayesian-based Model Validation (BMV) Methodology

- Methodology Overview
- REXIS Solar X-ray Monitor (SXM) Case Study

#### Conclusion

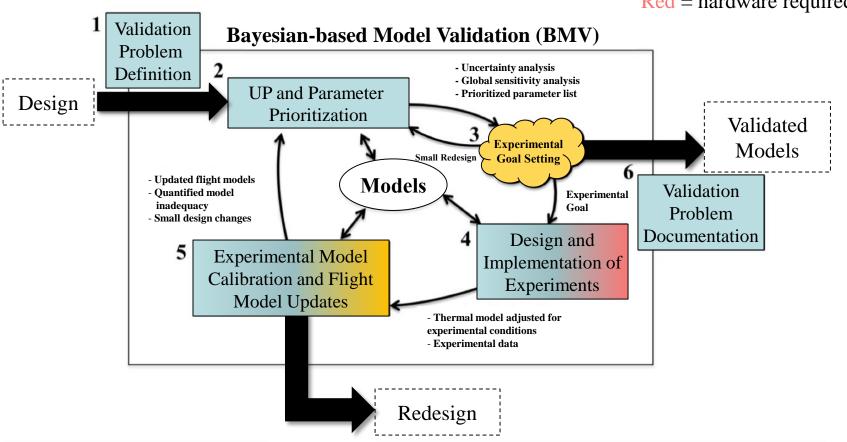
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#### **BMV Methodology Overview**

Blue = analyses
Orange = decision
Red = hardware required



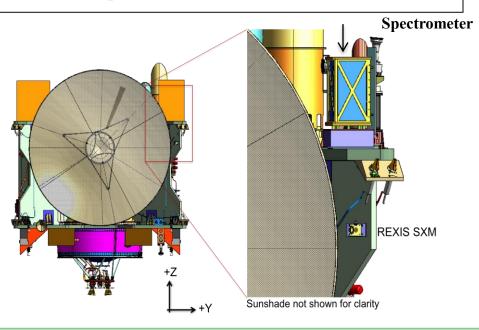


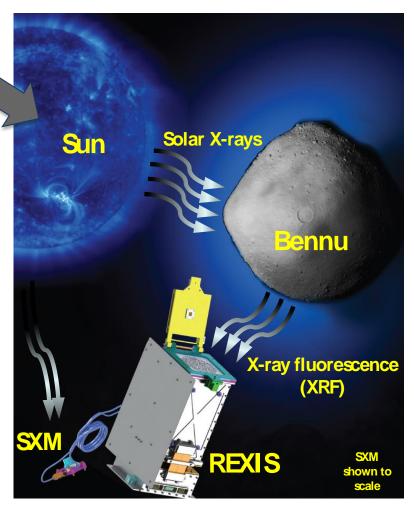
## REXIS Solar X-ray Monitor (SXM) Case Study



### **REgolith X-ray Imaging Spectrometer (REXIS)**

- One of five payload instruments on OSIRIS-REx
- Complements and enhances other science instruments on OSIRIS-REx
  - Characterizes Bennu among known meteorite groups and map surface elemental distribution





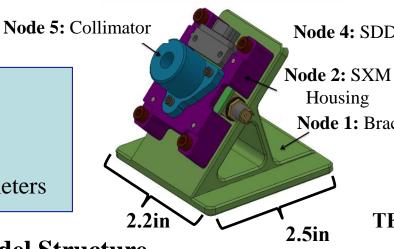
Two assemblies: spectrometer and Solar X-ray monitor (SXM). SXM observes timevariant solar X-ray spectrum to provide context to spectrometer measurements.



#### **Thermal Model Structure**

Five node lumped parameter model

- 38 total parameters
- 18 uncertain parameters



Node 4: SDD Housing
Node 2: SXM
Housing
Node 1: Bracket

TEC to cool SDD

Cho-Therm Pad

**Model Structure** 

EII	-> Environment							
Deep Space								
	Sun		$\nearrow\!\!\!<$	$\gg <$		R	R	
		O-REx						
		C	1 – Bracket					
			C	2 – SXM Housing				
				C	3 – SEB			
				C	C	4 – SDD Housing		
R				C			5 - Collimator	

$$\mathbf{y} = \eta_{SXM}(\mathbf{x})$$

Lumped parameter model provides y(x,t), temperatures versus time for each node

 $\rightarrow$  SXM

What is max allowable  $T_{O-REx}$ ?



#### **SXM Thermal Requirements**

At least 99% probability that all temperature ranges are satisfied



Component	Operational (°C)		
Component	Min	Max	
SDD Housing	-40	100	
SEB	-40	85	
SDD	-100	-30	

SDD = silicon drift detector

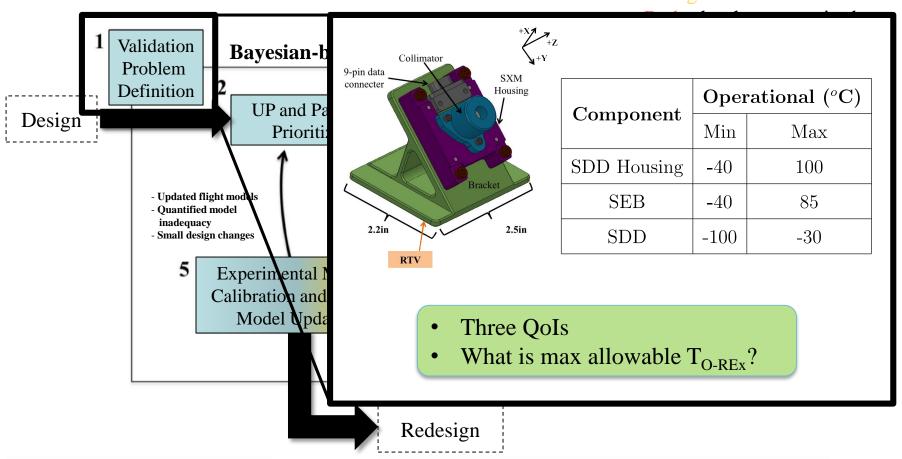
SEB = SXM electronics board

Three quantities of interest (QoIs) for SXM – all operational component temperature ranges



#### **Summary of SXM Case Study**

Blue = analyses Orange = decision



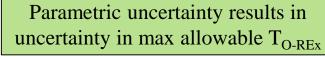


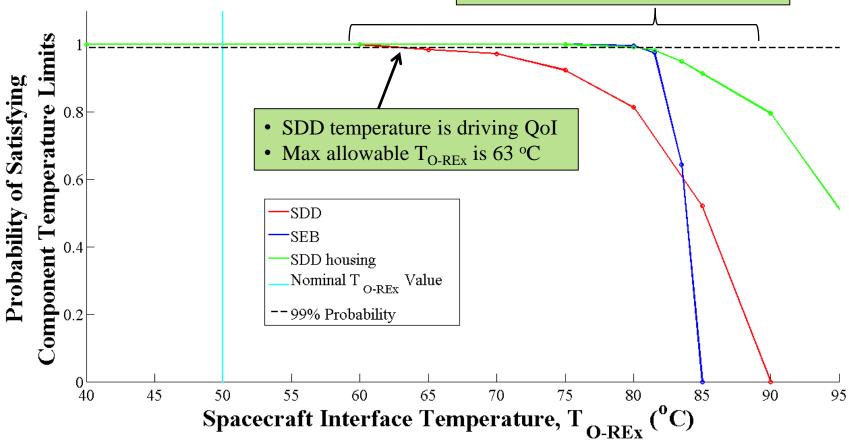
#### **Uncertainty Analysis**

#### Monte Carlo (MC) Simulation

$$\overline{\eta}_{SXM,N} = \frac{1}{N} \sum_{i=1}^{N} \eta_{SXM}(\mathbf{x}_i)$$

x contains all system and environmental parameters

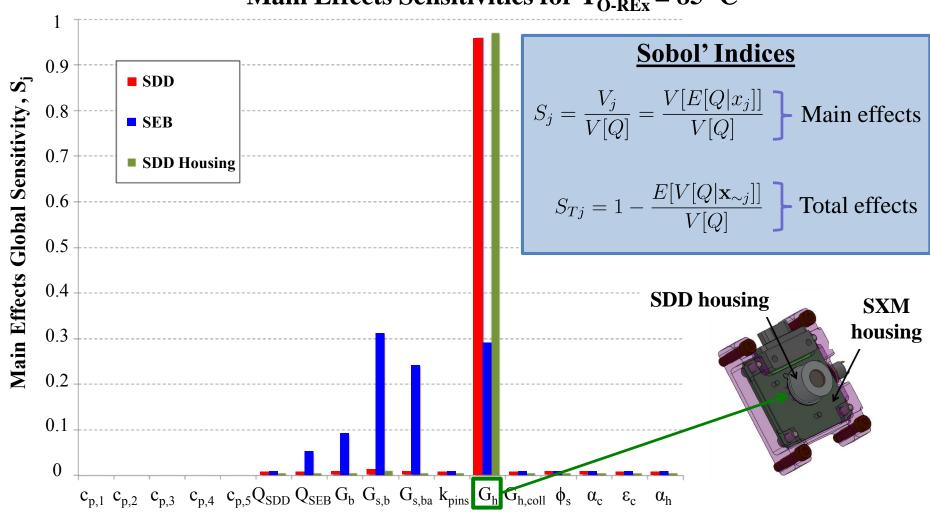






#### **Global Sensitivity Analysis**

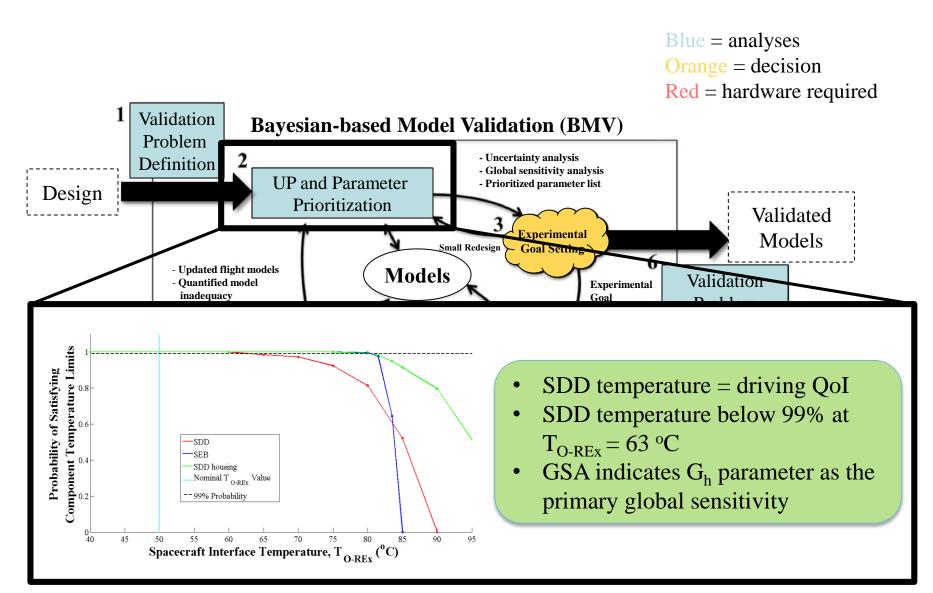
#### Main Effects Sensitivities for T<sub>O-REx</sub> = 85 °C



Conductance between SDD housing and SXM housing,  $G_h$ , is driving uncertain parameter for SDD and SDD housing temperatures

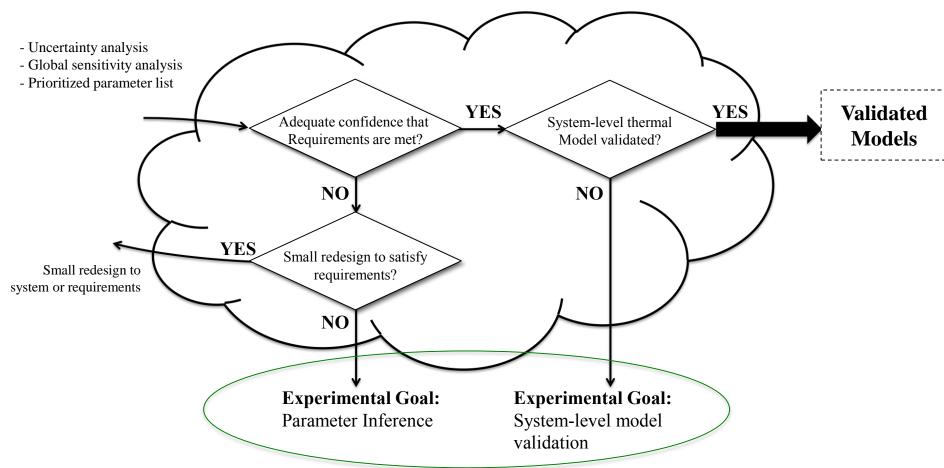


#### **Summary of SXM Case Study**





#### **Experimental Goal Setting**



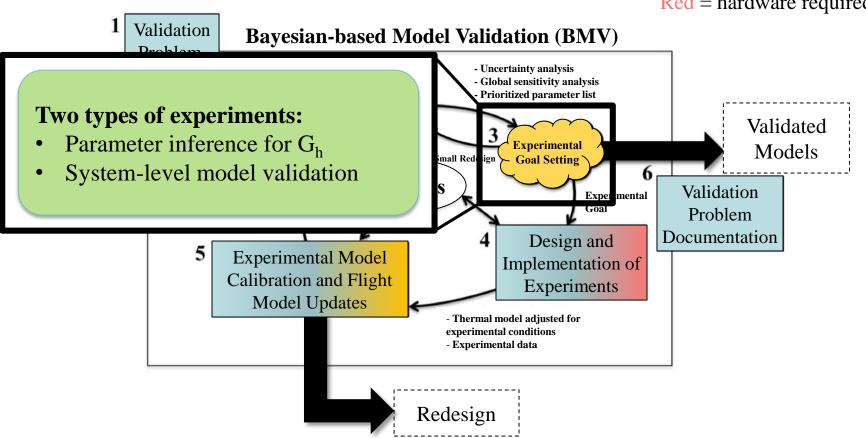
Two types of experiments will be implemented:

- Parameter inference experiment to reduce uncertainty in G<sub>h</sub>
- Model validation experiment to validate SXM thermal model



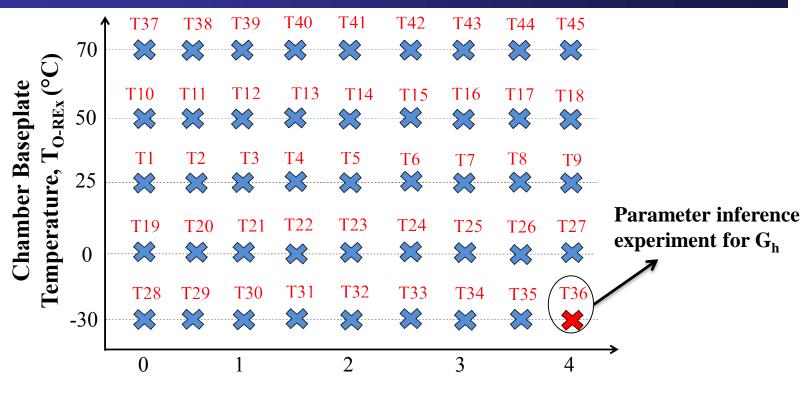
#### **Summary of SXM Case Study**

Blue = analyses
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#### **Model Validation Experiment**



TEC Voltage,  $V_{TEC}(V)$ 

- Full-factorial experiment (classical DOE)
- Small system time constant
- All test phases completed to steady state conditions

Validation experiment designed to span domain of expected TEC voltages and SXM interface temperatures



#### **Parameter Inference Experiment**

#### **Nomenclature**

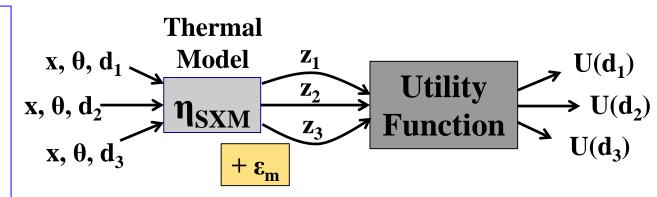
**x**: all model parameters

 $\theta$ : parameter(s) of interest,  $\theta = G_h$ 

d: experimental conditions,

$$\mathbf{d} = [T_{O-REx}, V_{TEC}]^T$$

z: experimental result/data



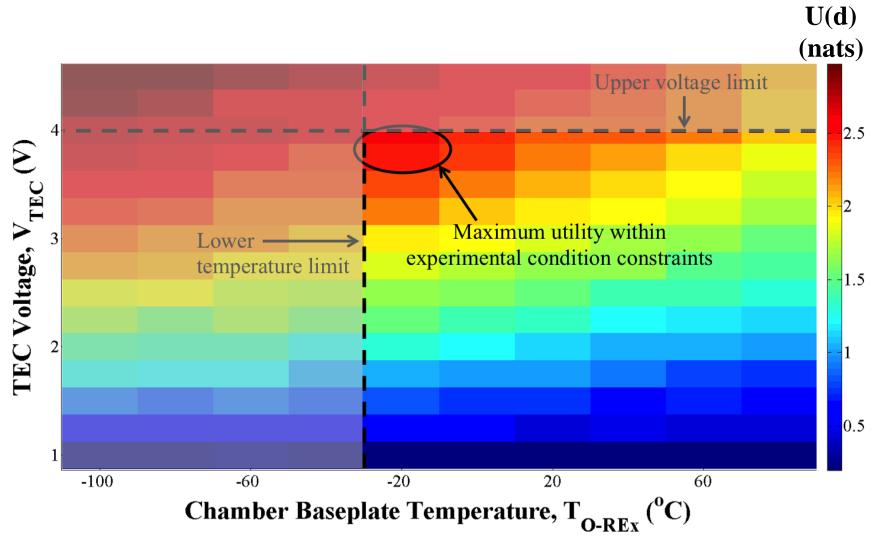
#### Table of Experimental Design Conditions, d

Name	Variable	DOE Variable	Units	Nominal Value	Minimum Value	Maximu m Value
Temperature of O-REx Deck	T <sub>O-REx</sub>	$d_1$	°C	40	-100	75
TEC Voltage	V <sub>TEC</sub>	$d_2$	V <sub>DC</sub>	3.0	0	4.5

Two experimental design conditions varied to create different parameter inference experiments for G<sub>h</sub>



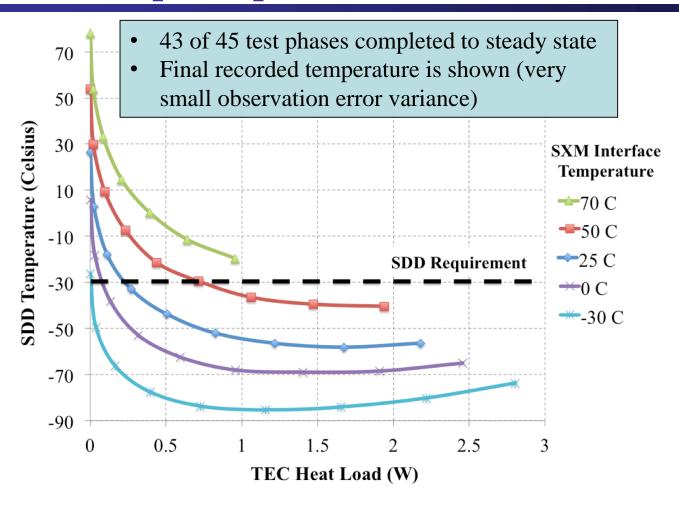
#### **Parameter Inference Experiment**



d\* is  $T_{O-REx} = -30$  °C,  $V_{TEC} = 4.0$  V, and  $T_w = 23$  °C



#### **Sample Experimental Results**

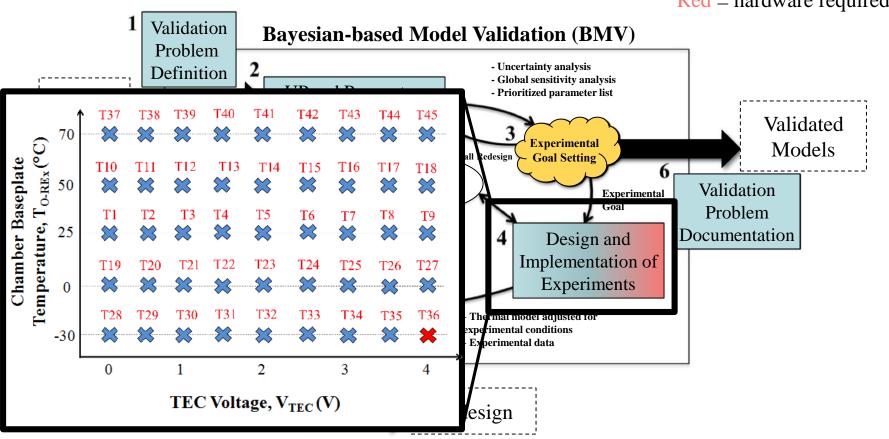


- Max expected TEC power is <2.0 W
- Preliminary thermal model has good predictive accuracy for SDD temperature



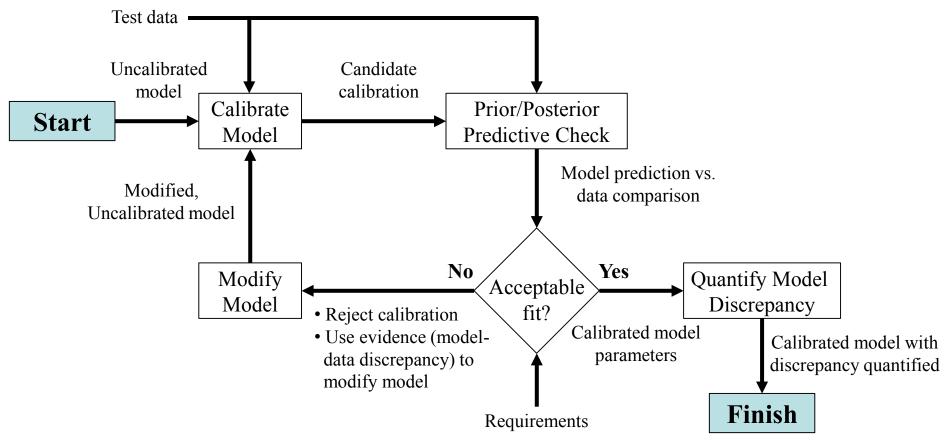
#### **Summary of SXM Case Study**

Blue = analyses Orange = decision Red = hardware required





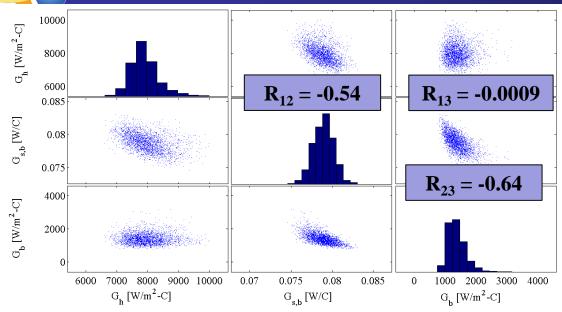
#### **Model Calibration Process Overview**



General process for calibration of model parameters and quantifying the model inadequacy



#### **Markov Chain Monte Carlo Results**

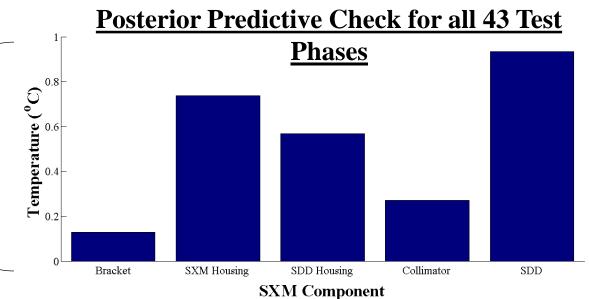


$$|\Delta T_{avg}| = \frac{1}{P} \sum_{i=1}^{P} |E[\eta_{SXM}(\mathbf{x}, \mathbf{d}_i)] - z_i|$$



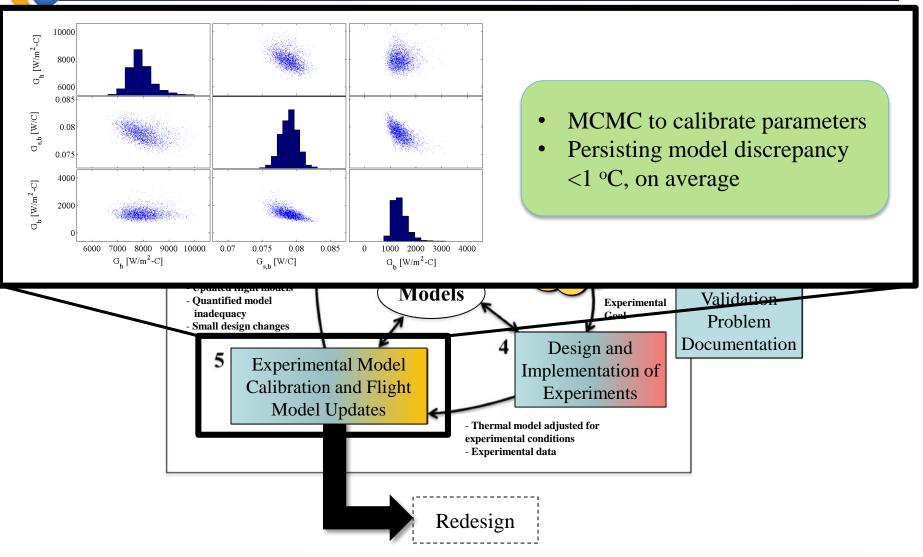
On average, difference between model prediction and data is less than 1 °C

Posterior parameter distributions yield acceptable fit to all data





#### **Summary of SXM Case Study**



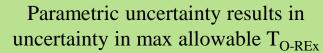


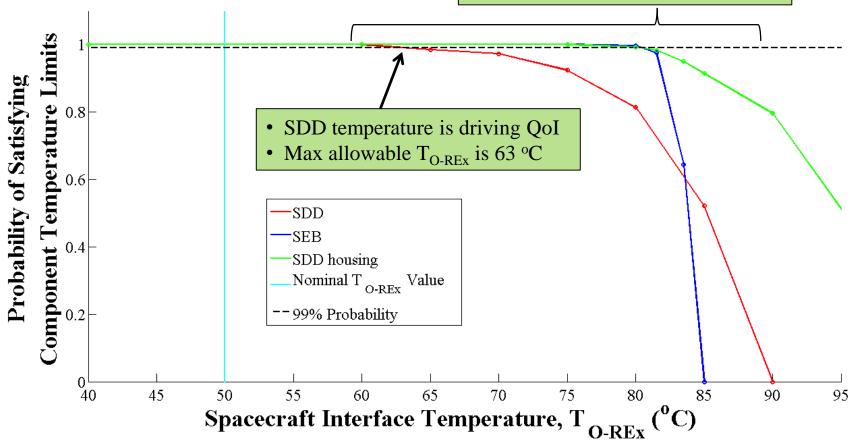
#### **Uncertainty Analysis**

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$$\overline{\eta}_{SXM,N} = \frac{1}{N} \sum_{i=1}^{N} \eta_{SXM}(\mathbf{x}_i)$$

x contains all system and environmental parameters



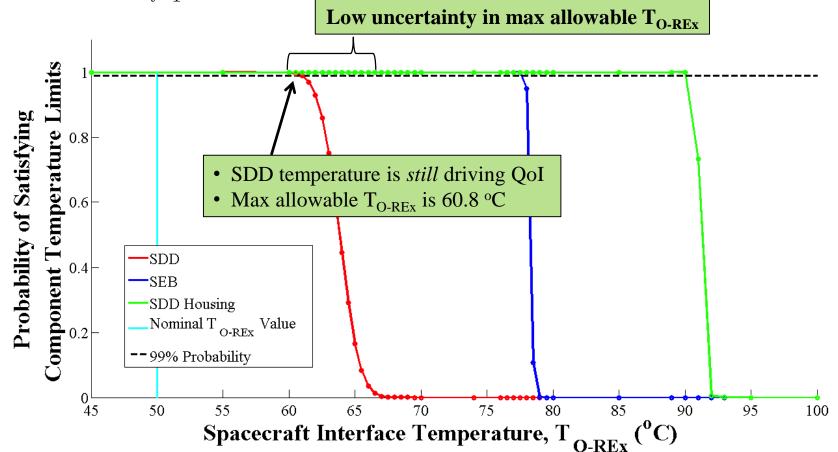




#### **Updated Uncertainty Analysis**

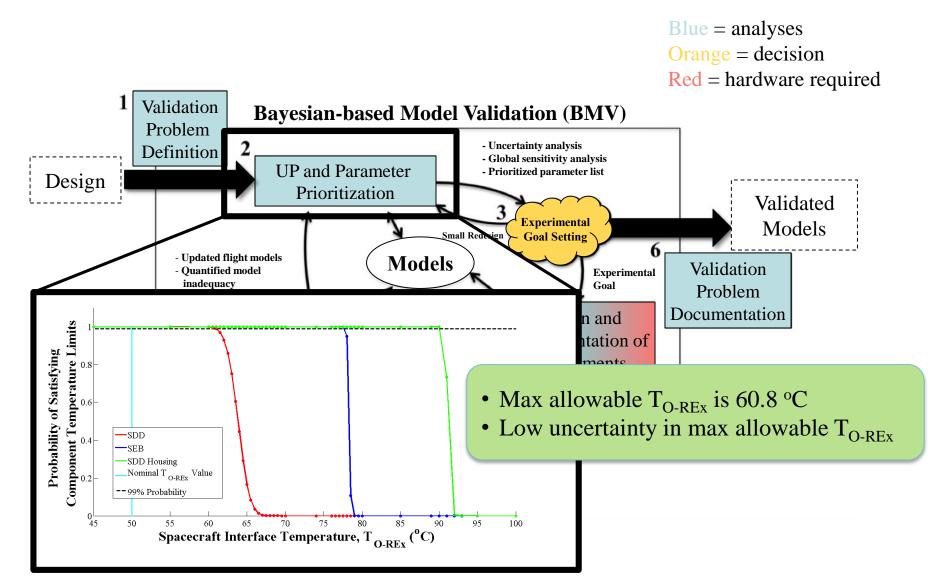
$$\zeta_{SXM}(\mathbf{x}) = \eta_{SXM}(\mathbf{x}) + \delta(\mathbf{d})$$
 } True physical process,  $\zeta_{SXM}$ 

$$\overline{\zeta}_{SXM,N} = \frac{1}{N} \sum_{i=1}^{N} \zeta_{SXM}(\mathbf{x}_i)$$
 Monte Carlo simulation of true physical process



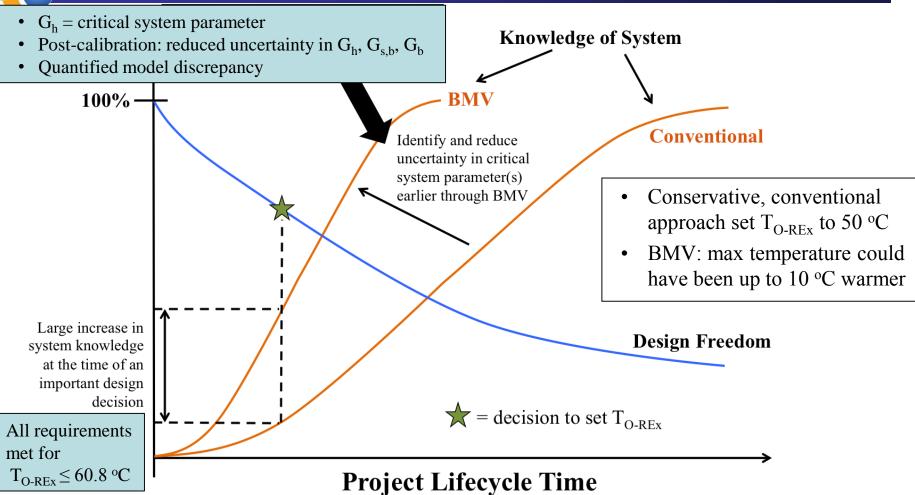


#### **Summary of SXM Case Study**



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#### **BMV Motivation – SXM Case Study**



Potential to increase knowledge of the system earlier in the project lifecycle when important design decisions are made



#### **Conclusion**

- Application of state of the art model uncertainty methods for thermal systems
- Created BMV methodology using state of the art UQ and DOE
- Implemented BMV on REXIS hardware
  - System level form and validation process improvements
- Future work:
  - Demonstrate BMV on larger, more complex thermal systems
  - Improve BMV interface with Thermal Desktop
  - Create databases of parameter uncertainty distributions

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#### **References – SXM Case Study**

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# **Backup Slides**



# **Posterior Sampling Formulation**

#### **Calibration Parameters**

$$\gamma = [G_h, G_{s,b}, G_b]^T$$

#### **Bayes' Theorem**

$$p(\gamma | \mathbf{z}, \mathbf{x}) = \frac{p(\mathbf{z} | \gamma, \mathbf{x}) p(\gamma)}{p(\mathbf{z} | \mathbf{x})}$$

# Metropolis-Hastings Algorithm [28,29], method for Markov Chain Monte Carlo (MCMC)

- 1. Draw proposal,  $\gamma_{new}$ , from  $q(\gamma_{new}|\gamma_{old})$
- 2. Calculate acceptance ratio:

$$\alpha(\gamma_{old}, \gamma_{new}) = \left[1, \frac{\pi(\gamma_{new})q(\gamma_{old}|\gamma_{new})}{\pi(\gamma_{old})q(\gamma_{new}|\gamma_{old})}\right]$$

3. Set the next value in the chain:

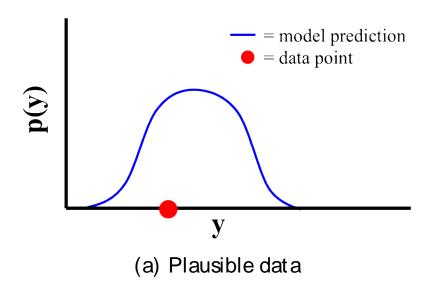
$$\gamma_{n+1} = \begin{cases} \gamma_{new} & with \ probability \ \alpha(\gamma_{old}, \gamma_{new}) \\ \gamma_{old} & with \ probability \ 1 - \alpha(\gamma_{old}, \gamma_{new}) \end{cases}$$

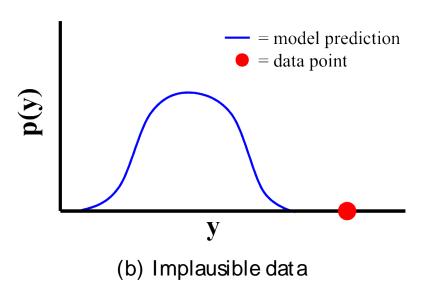
where 
$$\pi(\gamma) = p(\gamma | \mathbf{z}, \mathbf{d}) \propto p(\mathbf{z} | \gamma, \mathbf{d}) p(\gamma)$$

**Bayesian inference**: given the test data, MCMC is used to sample the posterior distributions of the calibration parameters



# **Posterior Check Explanation**

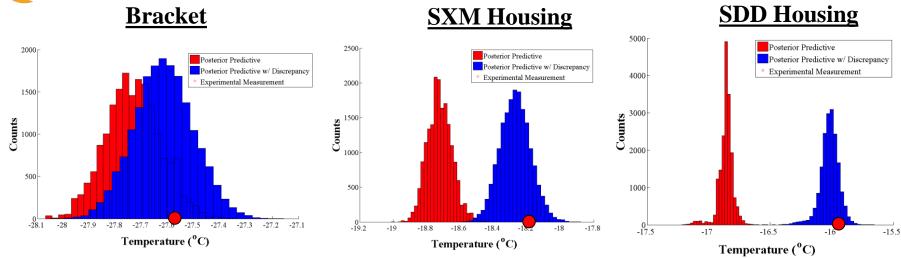




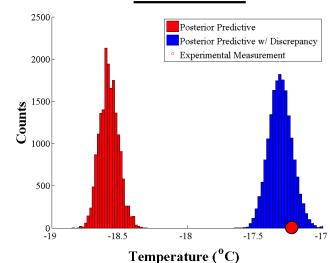
- Calibration parameters:  $\gamma = [G_h G_{s,b} G_b]^T$
- All other parameters in **x** are fixed



# **Posterior Predictive Check for T36**







Model discrepancy function improves model accuracy (all data plausible under model output)



# **Model Discrepancy Formulation**

- Kennedy-O'Hagan formulation [22], additive model discrepancy
- Gaussian Process (GP) models
- Squared Exponential ARD covariance kernel

$$\delta(\mathbf{x}) = \mathbf{z} - \eta_{SXM}(\mathbf{x}, \gamma) - \epsilon_m$$

$$\downarrow \qquad \qquad \downarrow \qquad \qquad \downarrow$$
discrepancy experimental calibrate observation observations d model

function of **d** only

$$\delta(\mathbf{d}) \sim \mathcal{GP}(m(\mathbf{d}), k(\mathbf{d}, \mathbf{d}')) = \mathcal{GP}(0, k(\mathbf{d}, \mathbf{d}'))$$

Zero-mean Gaussian Process, each discrepancy term is an independent function

$$\delta(\mathbf{d}) = \begin{pmatrix} \delta_b \\ \delta_{sxm,h} \\ \delta_{sdd,h} \\ \delta_{coll} \\ \delta_{sdd} \end{pmatrix}$$

$$5x1 \text{ vector corresponding to measurements on 5}$$

$$SXM \text{ components}$$

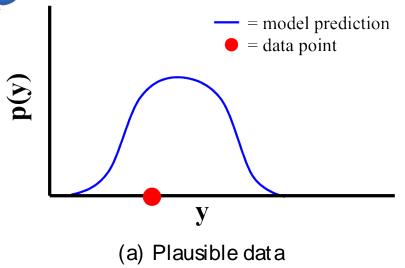
corresponding to measurements on 5

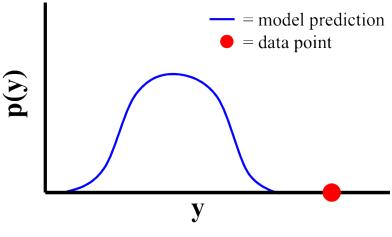
$$k(\mathbf{d}, \mathbf{d}') = \sigma_0^2 \exp\left\{-\frac{1}{2} \left(\frac{V_{TEC} - V_{TEC}'}{\lambda_1}\right)^2 + -\frac{1}{2} \left(\frac{T_{O-REx} - T_{O-REx}'}{\lambda_2}\right)^2\right\}$$

Squared exponential Automatic Relevance Determination (ARD) covariance kernel

GP models used to quantify the calibrated model discrepancy for all 43 test phases

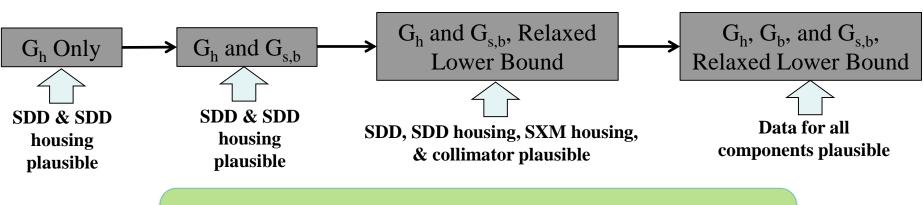
# Calibration Parameter Selection — = model prediction





(b) Implausible data

#### **Prior Predictive Check Sequence**

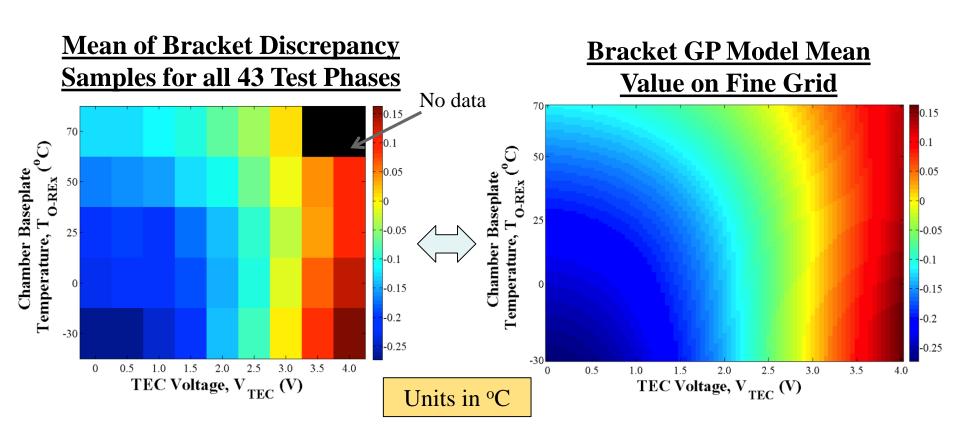


Calibration parameters:  $\gamma = [G_h G_{s,b} G_b]^T$ All other parameters in **x** are fixed



# **GP Model Regression Results**

GP regression used to find hyperparameter values  $(\sigma_0, \lambda_1, \lambda_2)$  for each discrepancy function



By inspection, regressed GP model mean is a good approximation of the mean of the discrepancy samples



# **Key Definition**

### **Simulation Model Validation**

Process of confirming a model is an adequate representation of the system and is capable of predicting the system's behavior *accurately* with respect to requirements over the domain of the intended application of the model [3,4]



# **Background – Thermal Simulation Models**

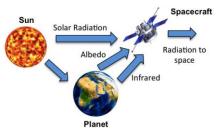
#### **Parameters**

System component geometry, connectivity, and material properties

Power dissipation of spacecraft components

#### **General Spacecraft Thermal Environment**

Thermal Environment



#### Model

#### **General Heat Transfer Equation**

$$\Gamma c_p \frac{\partial T}{\partial t} = \nabla \cdot k(\nabla \cdot T) + Q(T, t)$$

Symbol	Variable	
ρ	Density	
c <sub>p</sub>	Specific heat	
k	Conductivity	
Q(T,t)	Source heat	

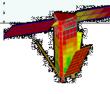
#### **Thermal Analysis Tools**

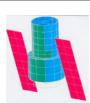
- Analytical models
- Lumped parameter models
- Commercially available software packages
  - TSS/SINDA and Thermal Desktop (Finite Difference)

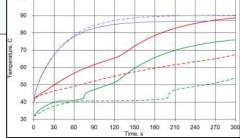
Increasing fidelity

#### Output

Predictions for spacecraft component temperatures for a given operational mode and thermal environment.

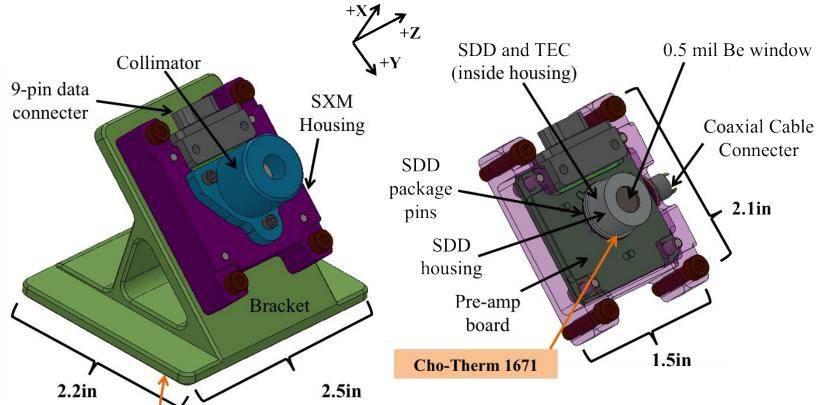








# **SXM Thermal Design Overview**



What is max allowable  $T_{O-REx}$ ?

**RTV** 

- Thermoelectric cooler (TEC) to cool SDD
- Conduction dominates
- Thermally coupled to OSIRIS-REx interface,  $T_{O-REx}$
- Nominally,  $T_{O-REx} = 50 \text{ }^{\circ}\text{C}$

# **Experimental Set-Up**

#### **Example model modifications**

- Include sensor/observation error,  $\varepsilon_{\rm m}$
- Thermal vacuum wall temperature is external radiation sink
- No sunlight
- TEC not software-controlled

#### **Nomenclature**

**x**: all model parameters

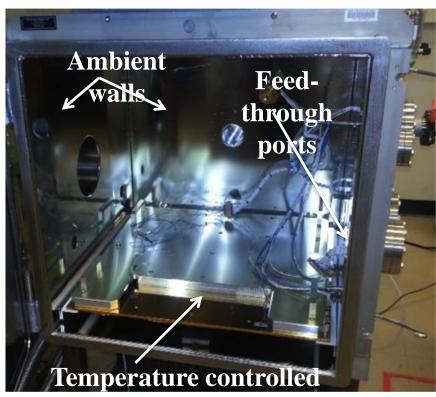
 $\theta$ : parameter(s) of interest  $\theta = G_h$ 

d: experimental conditions,

$$\mathbf{d} = [T_{O-REx}, V_{TEC}, T_{w}]^{T}$$

z: experimental result/data

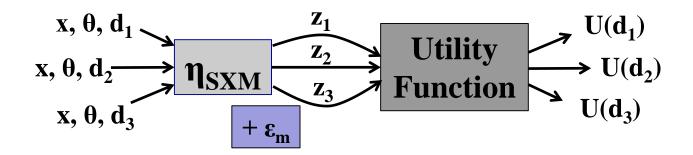
#### **SSL Thermal Vacuum Chamber**



SSL chamber used for both parameter inference and model validation experiments



# **Parameter Inference Experiment**



# The Kullback-Leibler (KL) divergence utility function:

$$u(\mathbf{d}, \mathbf{z}, \theta) = D_{KL}(p(\theta|\mathbf{z}, \mathbf{d})||p(\theta))$$

inserted into Lindley's *expected* experimental utility form [21]:

$$U(\mathbf{d}) = E[D_{KL}(p(\theta|\mathbf{z}, \mathbf{d})||p(\theta))]$$

$$U(\mathbf{d}) \approx \frac{1}{n_{out}} \sum_{i=1}^{n_{out}} \left( ln[p(\mathbf{z}_i | \theta_i, \mathbf{d})] - ln[p(\mathbf{z}_i | \mathbf{d})] \right)$$
$$p(\mathbf{z}_i | \mathbf{d}) \approx \frac{1}{n_{in}} \sum_{j=1}^{n_{in}} p(\mathbf{z}_i | \theta_{i,j}, \mathbf{d})$$

$$\mathbf{d}^* = \max_{\mathbf{d} \in \mathcal{D}} U(\mathbf{d})$$



- Interpretation of probability: instead of quantifying "frequency" or "propensity," a Bayesian probability is a quantity defining a state of knowledge
- Bayesian inference
  - Given new information, the probability is updated via Bayes' Theorem
- Broadly applicable to many engineering disciplines
  - "Natural" fit to many engineering problems
  - "Common sense" interpretation of statistical conclusions

#### **Bayes' Theorem**

$$p(\gamma | \mathbf{z}, \mathbf{x}) = \frac{p(\mathbf{z} | \gamma, \mathbf{x}) p(\gamma)}{p(\mathbf{z} | \mathbf{x})}$$

#### **Comparison of Probability Interpretations\***

	<u> </u>
Frequentists	Bayesians
Probabilities represent long term frequencies of repeatable random experiments	Probabilities describe the incomplete knowledge of a fixed parameter or quantity
Data are repeatable, random sample	Data observed from realized sample
Unknown parameters are constant Parameters are fixed	Parameters are unknown and described probabilistically  Data are fixed

<sup>\*</sup>Casella, George. "Bayesians and Frequentists." ACCP 37th Annual Meeting, Philadelphia, PA. Department of Statistics, University of Florida.

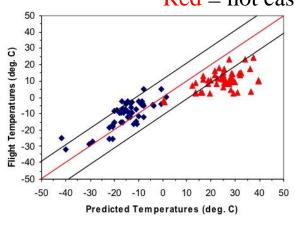


# **Motivation – Evidence\* (Welch 2006)**

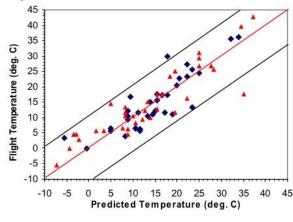
Flight Program	Model vs. Flight Temperature Difference μ ± 2σ (°C)	Derived Thermal Uncertainty Margin (°C)
DOD Program A	+5.9 ± 10.0	15.9
DOD Program B	+1.3 ± 8.4	9.7
Iridium	-3.3 ± 11.9	15.2
NASA TIMED	+4.3 ± 11.2 (cold) -13.5 ± 15.6 (hot)	15.5 29.1
DOD Program C	+6.6 ± 9.0	15.6
DOD Program D	+0.5 ± 10.0	10.5
ESA Italsat-1	+2.2 ± 7.8	10.0
ESA Italsat-2	-1.5 ± 7.7	9.2
ESA SAX	-3.1 ± 6.6	9.7

- Revisited military standards for uncertainty margin
- Examined variety of programs, e.g. military, NASA, and ESA programs

#### Red = hot cases, Blue = cold cases



(a) NASA TIMED



#### (b) DOD Program D

#### (a) NASA TIMED

- Very biased thermal model
- Intermediate environments significantly more benign than worst-case hot scenario

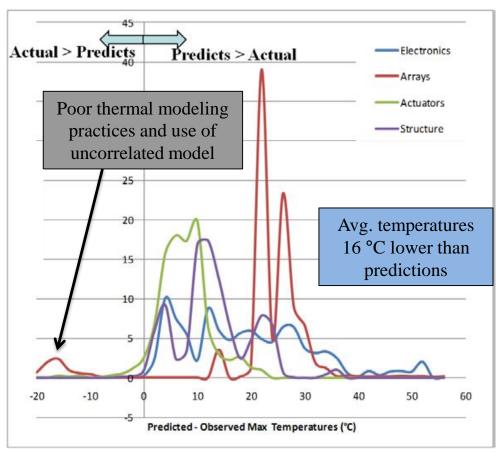
#### (b) DOD Program D

- Very little model bias, i.e.
   mean near zero
- Large variance about hot/cold case mean



# Motivation – Evidence\* (Karpati et al. 2012)

# Flight temperatures vs. model predictions for seven recent GSFC missions\*\*



- \*All data from Karpati, et al. [5]
- \*\*Daily/orbit max temperatures polled for 209 sensors for entire life of missions.

- Nearly all worst hot case predicted temperatures greater than those observed
  - Results agree with Welch [11] and Peabody, et al. [12]
  - Evidence that stacked worst case scenarios have low likelihood/frequency
- Estimated that the 5 °C NASA uncertainty margin [17] will result in radiator mass growth between 0.3-0.7 kg per 100 W heat load
  - Radiator growth leads to power draw increase of 4-6 W per 100 W heat load for survival heaters



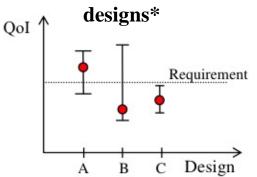
# **Uncertainty Propagation (UP)**

#### State of the Art

#### **Uncertainty Propagation Process [13]**

- Goal setting
- Model selection and documentation
  - Surrogate modeling
- Uncertainty classification
- Uncertainty characterization
- Uncertainty Analysis (UA)
- Sensitivity Analysis (SA)

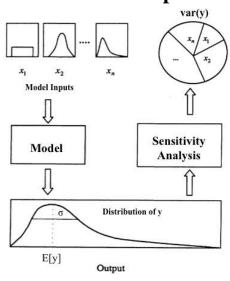
# UA for three different designs\*



\*S.A. Uebelhart, D. Miller, and C. Blaurock. Uncertainty Characterization in Integrated Modeling. AIAA Structures, Structural Dynamics and Materials Conference, 46:2005–2142, April 2005.

\*\*A. Saltelli, S. Tarantola, and K.P.-S. Chan. A Quantitative Model-Independent Method for Global Sensitivity Analysis of Model Output. Technometrics, 41(1):39–56, 1999. American Statistical Association and the American Society for Quality.

#### Global SA concept\*\*



#### **Thermal Convention**

Most programs follow the philosophy in NASA GOLD Rules [17]:

**Rule**: Use model to show adequate margin between component temperature limits and stacked worst case temperature predictions.

**Rationale**: Positive margins account for uncertainties in power dissipations, environments, and thermal system parameters.

# Stacked worse case scenarios [1]

- Heat loads
- Coating degradations
- Power dissipations
- Beta angles
- Critical conductances
- MLI e\*



# **Design of Experiments (DOE)**

#### State of the Art

#### Classical DOE

- Ronald Fisher [18,19]
  - Est. null hypothesis
- Principles of DOE
  - Randomization, blocking, replication, orthogonality
- No unified strategy and predefined experiments for general system

# Optimal Bayesian Experimental Design (OBED) Culminate to Huan and Marzouk [21]:

Bayesian statistics offer inference from noisy, indirect, and incomplete data.

- *Update* prior parameter distributions to reduce uncertainty
- Framework allows for *different experimental goals*, e.g. parameter inference
- Measure utility based on experimental result
  - Utility function based on predictive variance or parameter of interest, e.g. Kullback-Leibler divergence

#### Thermal Convention

- Models validated through thermal balance testing
- Classical DOE approach (same testing philosophy):
  - NASA GEVS [17]
  - Military MIL-STD-1540 [15] and MIL-HDBK-340 [16]
  - Other, e.g. universities

What cases and how a system should be tested to achieve model validation

- Test levels
- Environmental conditions
- Duration

**Min Requirement**: Two test conditions shall be imposed: one each at mission hot and cold case. NASA engineers shall select one additional case, per GEVS.

**Primary Objective**: Validate the design/model, which will be used to make predictions for the entire range of modes/mission environments.



### **Model Calibration**

#### State of the Art

#### **Parameter optimizations**

- Cullimore [#]
- Masterson [#]

Focuses only on parameters

#### **Bayesian Calibration**

<u>Seminal Paper – Kennedy and O'Hagan [22]</u>

- General Bayesian calibration framework
- Non-linear, black box models
- Captures all parametric and non-parametric uncertainties
- Model inadequacy quantified after experiment



#### **K-O Approach Enhancements**

- Brynjarsdottir and O'Hagan [#]
  - Model the model inadequacy
- Higdon et al. [#]
  - High dimensional output
- Bayarri et al. [#]
  - Model validation framework

#### **Thermal Convention**

Correlation process outlined by Gilmore [1] followed for most space-based thermal systems:

- 1. Configure model based on environment and power modes tested
- 2. For a single test phase, adjust model to match data. Common adjustments to the model include:
  - Physical model omissions, i.e. model

inadequacy

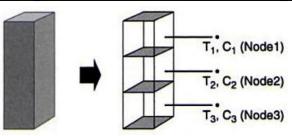
- View factor geometries
- Conductances
- Power dissipations
- 3. Correlate all temperature differences between model and test data to less than some threshold value, e.g. ±3°C per MIL-HDBK-340 [16]
- 4. Repeat 2-3 for the remaining test phases, ensuring that changes made in each remaining phase do not undo the correlation from a previous phase

Ad hoc search for best fitting model parameters: relies heavily on engineering experience and intuition.

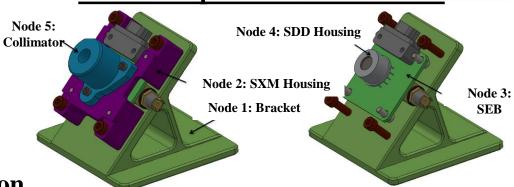


# **Model Formulation**

#### **Lumped Parameter Concept [1]**



#### **SXM Lumped Parameter Nodes**



#### **Model Formulation**

$$\mathbf{y} = \eta_{SXM}(\mathbf{x})$$
 where the three QoIs are identified in the output  $\mathbf{Q} \subset \mathbf{y} \; ext{and} \; \mathbf{Q} = [T_h, T_{pa}, T_{sdd}]^T$ 

$$\mathbf{Q} \subset \mathbf{y} \text{ and } \mathbf{Q} = [T_h, T_{pa}, T_{sdd}]^T$$

Governing differential equation of form:  $\frac{d\Gamma}{dt} = f(T, t)$  where the nodal temperatures are  $\Gamma = [T_1 \ T_2 \ ... \ T_n]^T$ 

#### **Simplifying Assumptions:**

- Heterogeneous material globally, but the material assigned to each node is homogenous
- All SXM material is isotropic
- All material within a nodal region is isothermal

$$f(\mathbf{T},t) = \mathbf{C}^{-1}[\mathbf{GT} + \mathbf{Q}(\mathbf{T},t)]$$

$$T_{j}(t_{i+1}) = \underbrace{\Delta t}_{T_{j},t_{i}}^{dT} + T_{j}(t_{i})$$

$$Select \Delta t \text{ such that solver is stable}$$
and has acceptable error
$$C = \begin{pmatrix} G_{1,1} & G_{1,2} & \cdots & G_{1,n} \\ G_{2,1} & G_{2,2} & \cdots & G_{2,n} \\ \vdots & \vdots & \ddots & \vdots \\ G_{n,1} & G_{n,2} & \cdots & G_{n,n} \end{pmatrix}$$

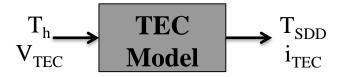
$$f(\mathbf{T},t) = \mathbf{C}^{-1}[\mathbf{GT} + \mathbf{Q}(\mathbf{T},t)]$$
  $\mathbf{C} = \begin{pmatrix} m_{1,1}c_{p1,1} & 0 & \cdots & 0 \\ 0 & m_{2,2}c_{p2,2} & \cdots & 0 \\ \vdots & \vdots & \ddots & \vdots \\ 0 & 0 & \cdots & m_{n,n}c_{p3,3} \end{pmatrix}$ 

$$\mathbf{G} = \begin{pmatrix} G_{1,1} & G_{1,2} & \cdots & G_{1,n} \\ G_{2,1} & G_{2,2} & \cdots & G_{2,n} \\ \vdots & \vdots & \ddots & \vdots \\ G_{n,1} & G_{n,2} & \cdots & G_{n,n} \end{pmatrix}$$



# **Prior SXM TEC Model**

#### Thermoelectric Cooler (TEC)



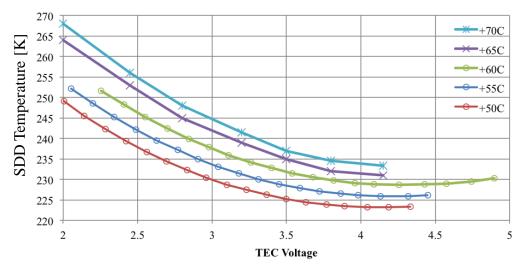
#### **Proportional Control to Setpoint, T<sub>s</sub>**

$$V(t_{i+1}) = K_p e(t) = K_p (T_{sdd} - T_s)$$

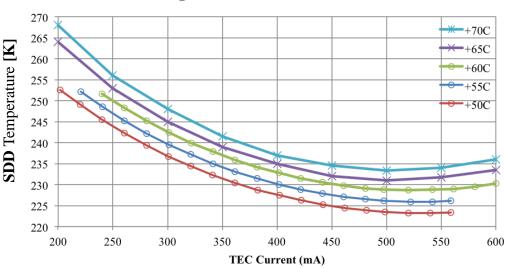
- Performance estimates provided by Amptek, Inc. used to predict SDD temperature
- Parameters of polynomial curves are fixed values
- In flight, V<sub>TEC</sub> will be controlled by flight software
- As the hot side temperature, T<sub>h</sub>, increases, more power is required

Thermal analysis uses TEC model and controller to focus on the ability of the TEC to achieve  $T_s = -30^{\circ}C$ .

#### **SDD Temperature vs TEC Voltage**

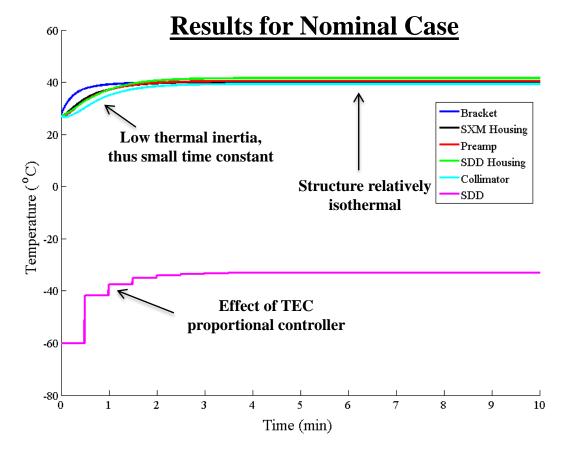


#### **SDD Temperature vs TEC Current**





### **SXM Model Nominal Parameters**



- 38 total parameters
  - 18 are uncertain or naturally exhibit variation
- What is meant by nominal?
  - Default design value
  - Current best estimate
  - Median parameter value

#### **Requirements**

Component	Operational (°C)		
Component	Min	Max	
SDD Housing	-40	100	
SEB	-40	85	
SDD	-100	-30	

Nominally, all three steady-state temperature requirements are satisfied

# **SXM Model Uncertain Parameters**

Parameter Number	Name	Variable	Units	Nominal Value	Distribution Type	Parameter 1 (minimum)	Parameter 2 (maximum)	
	Node Specific Heats							
1	1 - Bracket	$c_{p,1}$	J/kg-K	961	Uniform	921	972	
2	2 – SXM Housing	$c_{p,2}$	J/kg-K	961	Uniform	921	972	
3	3 – Pre-amp board	$c_{p,3}$	J/kg-K	800	Uniform	378	880	
4	4 SDD Housing	$c_{p,4}$	J/kg-K	461	Uniform	378	461	
5	5 - Collimator	$c_{p,5}$	J/kg-K	961	Uniform	921	972	
			Power D	issipations				
6	SDD	$Q_{\mathrm{SDD}}$	W	0.01	Uniform	0	0.01	
7	Pre-amp board	$Q_{PA}$	W	0.20	Uniform	0	0.25	
			Conduction	n Parameters				
8	Temperature of O-REx Deck	T <sub>O-REx</sub>	°C	40	Uniform	-30	50	
9	Conductance between O-REx and bracket	$G_b$	W/m <sup>2</sup> -C	2,000	Uniform	100	4,000	
10	Conductance per screw between bracket and SXM housing	$G_{s,b}$	W/C	0.42	Uniform	0.11	1.32	
11	Conductance per screw between preamp and SXM housing	$G_{s,pa}$	W/C	0.26	Uniform	0.07	0.80	
12	Conductivity of pins on SDD package	k <sub>pins</sub>	W/m-°C	400	Uniform	350	405	
13	Conductance between SDD housing and SXM housing	$G_{h}$	W/m²-C	2,000	Uniform	100	4,000	
14	Conductance per screw between collimator and SXM housing	$G_{s,coll}$	W/C	0.21	Uniform	0.03	0.42	
			Radiation	Parameters				
15	Solar Flux	$\phi_{\rm s}$	W/m²	1,367	Uniform	700	1,752	
16	Collimator Absorptivity	$\alpha_{\mathrm{c}}$		0.50	Uniform	0.31	0.60	
17	Collimator Emissivity	$\epsilon_{\rm c}$		0.80	Uniform	0.78	0.82	
18	SDD Housing Absorptivity	$\alpha_{\rm h}$		0.50	Uniform	0.30	0.52	



# **Fourier Amplitude Sensitivity Testing (FAST)**

- Variance-based global sensitivity analysis method
- Can be more efficient to evaluate "main" or "total" effect sensitivity indices over other methods

Explore N-dimensional space of model parameters via search curve defined by parametric equations

$$X_i = G_i \sin(W_i s)$$

s ~ scalar from [-inf,+inf]  $G_i$  ~ transfer function  $\omega_i$  ~ frequencies

In classic FAST, main effects sensitivities are approximated via Fourier coefficients



# **Sensor Importance Study**

- **Objective**: identify through analysis which temperature sensors are most important w.r.t. experimental utility
- Procedure can be used to answer:
  - Where to measure?
  - How accurately to measure?
- Value in knowing sensor importance:
  - Sensor could fail during test
  - Addition of redundant sensors for critical locations
  - Testbed may have sensor quantity restrictions
  - Planned sensor may not be possible to install on system

Occurred on SXM – not possible to place RTD on SXM electronics board. Vector of observations, z, is now 5x1.

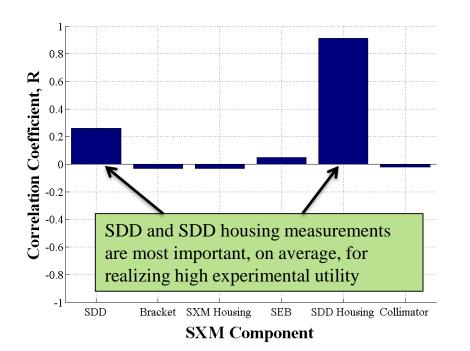
#### **Pearson's Correlation Coefficient**

$$R_{A,B} = \frac{cov(A,B)}{\sigma_A \sigma_B}$$

Will indicate whether the presence of a sensor is, on average, correlated to high utility

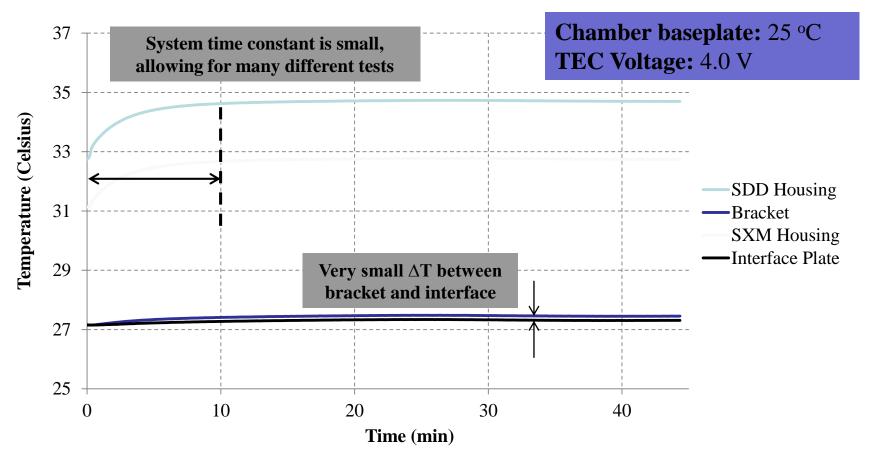
#### **Matrix of Sensor Permutations (64x6)**

1	$\prime_{Bracket}$	SXMHousing	SEB	SDDHousing	Collimator	SDD
	0	0	0	0	0	1
ı	0	0	0	0	1	0
	0	0	0	0	1	1
ı	:	<b>:</b>	:	:	:	:
	1	1	1	1	1	1 /





# **Experimental Results: Sample for T9**



SXM thermal time constant is approximately 10 min due to small thermal capacitance.

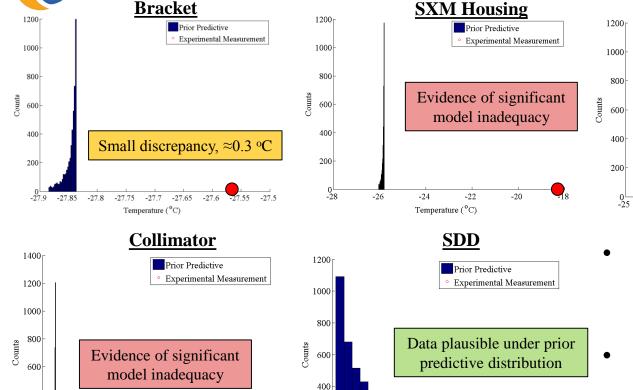
# Prior Predictive Check (PPC): G<sub>h</sub> Only

-72

Temperature (°C)

-71

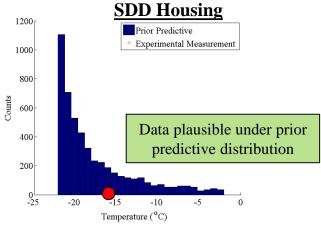
-70



200

-74

-73



- Propagate prior uncertainty through SXM thermal model
- All parameters have fixed values except for G<sub>h</sub>
- PPC for only test phase T36 (4.0 V, -30 °C)

Current Parametric Model Uncertainty			
Parameter	Units	Min Value	Max Value
$G_h$	W/m <sup>2</sup> /C	100	4,000

-16

-20

-18

400

200

-24

-22

Temperature (°C)

Location of discrepancy and previous GSA suggests to repeat PPC including the uncertainty in conductance between SXM housing and bracket,  $G_{s,b}$ 

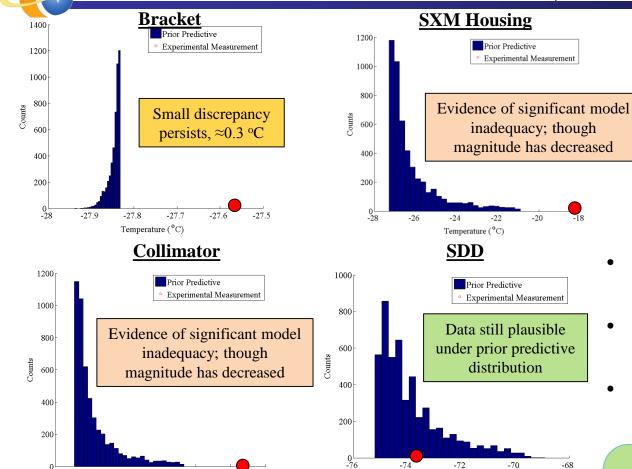
# **PPC:** G<sub>h</sub> and G<sub>s,b</sub> Only

-72

Temperature (°C)

-70

-68



Current Parametric Model Uncertainty			
Parameter	Units	Min Value	Max Value
$G_{h}$	W/m²/C	100	4,000
$G_{s,b}$	W/C	0.11	1.32

-20

-18

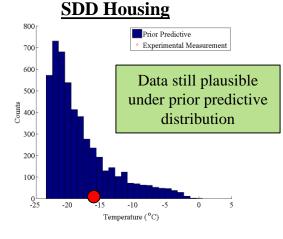
0 -28

-26

-24

-22

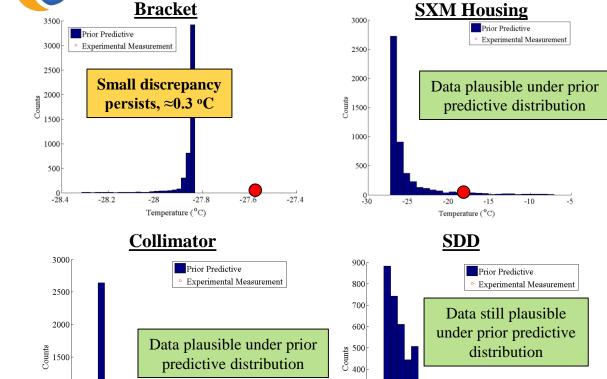
Temperature ( $^{\rm o}$ C)



- Propagate prior uncertainty through SXM thermal model
- All parameters have fixed values except for G<sub>h</sub> and G<sub>s,b</sub>
- PPC for only test phase T36  $(4.0 \text{ V}, -30 \text{ }^{\circ}\text{C})$

Improvement but lack of surface area near screw holes suggests to repeat PPC but reduce lower bound of G<sub>s,b</sub>

# PPC: G<sub>h</sub> and G<sub>s,b</sub> Only, Relaxed G<sub>s,b</sub> Lower Bound



300 200

100

0 -76

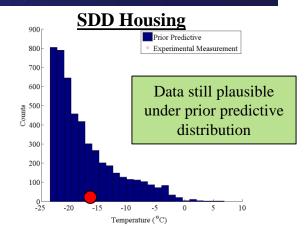
-74

-70

Temperature ( $^{\rm o}{\rm C}$ )

-68

-66



- Propagate prior uncertainty through SXM thermal model
- All parameters have fixed values except for  $G_h$  and  $G_{s,b}$
- PPC for only test phase T36 (4.0 V, -30 °C)

Current Parametric Model Uncertainty			
Parameter	Units	Min Value	Max Value
$G_{h}$	W/m <sup>2</sup> /C	100	4,000
$G_{s,b}$	W/C	0	1.32

-5

1000

500

0 -30

-25

-20

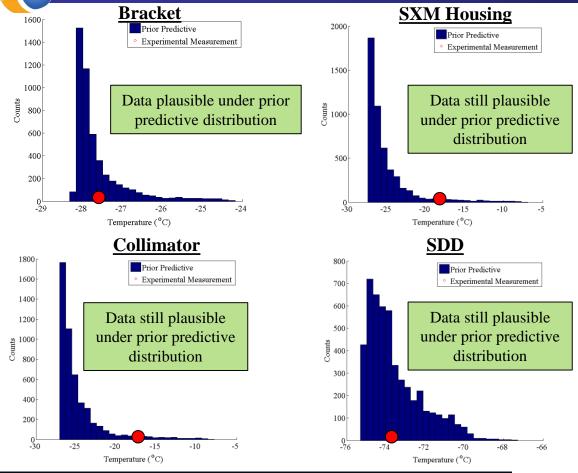
Temperature (°C)

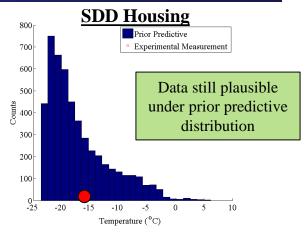
-15

-10

Persisting *small* discrepancy in bracket suggests to repeat PPC including uncertainty in conductance between bracket and interface, G<sub>b</sub>

# PPC: G<sub>h</sub>, G<sub>s,b</sub> and G<sub>b</sub> Only, Relaxed G<sub>s,b</sub> Lower Bound





- Propagate prior uncertainty through SXM thermal model
- All parameters have fixed values except for  $G_h$ ,  $G_{s,b}$  and  $G_b$
- PPC for only test phase T36 (4.0 V, -30 °C)

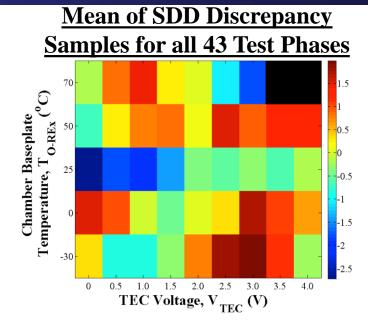
Current Parametric Model Uncertainty			
Parameter	Units	Min Value	Max Value
$G_{h}$	W/m <sup>2</sup> /C	100	4,000
$G_{s,b}$	W/C	0	1.32
$G_b$	W/m <sup>2</sup> /C	100	4,000

Current parametric uncertainty can explain all data for T36. Now, update parameter distributions and calibrate to *all* test phases.

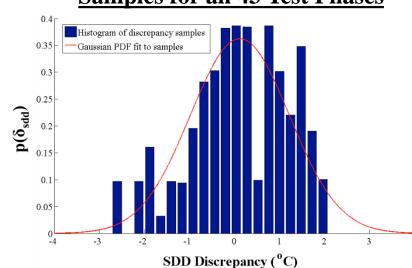
# **Quantify Calibrated Model Discrepancy for SDD**

- No obvious functional relationship between SDD temperature and  $V_{TEC}$ ,  $T_{O-REx}$
- Updated, empirical TEC thermal model under-predicts/over-predicts SDD temperature
  - If more accuracy were required, additional refinements to TEC model would increase predictive accuracy
- Histogram of all discrepancy samples for all 43 test cases reveals that discrepancy can be conservatively captured via Gaussian distribution

SDD discrepancy function will be stationary Gaussian distribution  $\rightarrow$  conservative approach because maximum possible discrepancy variance is considered for all possible  $V_{TEC}$ ,  $T_{O-REx}$ 



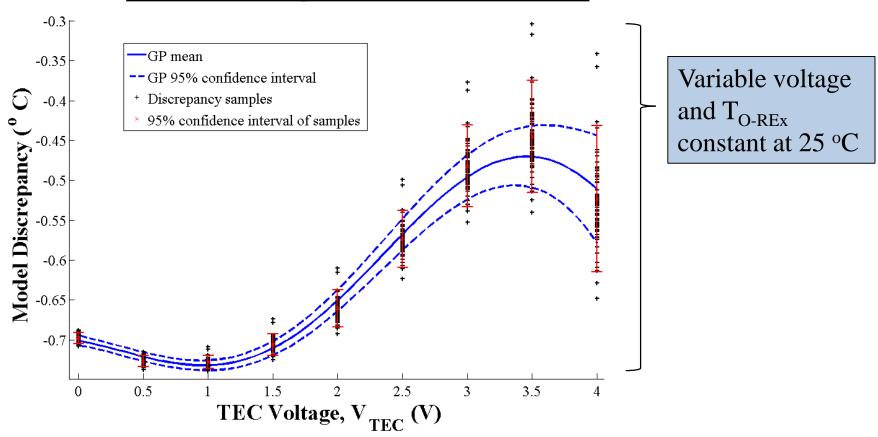
# Histogram of SDD Discrepancy Samples for all 43 Test Phases





# **GP Model – Sample Section**

### **SDD Housing – GP Model Section**



GP model section shows variance reduction and trends in discrepancy samples well-matched with discrepancy model

# Comparison of BMV to a Conventional Approach

Validation Step	Analogous BMV Step	BMV	A Conventional Approach
Analysis	2: UP and Parameter Prioritization	<ul> <li>All system and environmental parameters probabilistically characterized and propagated through model for many thousands of bounding and intermediate thermal cases; all requirements satisfied for T<sub>O-REx</sub> up to 50 °C</li> <li>Global sensitivity analysis uses information within model to rigorously, systematically identify critical system sensitivities; SXM conductance G<sub>h</sub> is critical sensitivity</li> </ul>	<ul> <li>Likely only two analysis cases, corresponding to worst-case hot and cold operational scenarios</li> <li>Identification of critical system sensitivity up to individual engineer; often manual local sensitivity analysis; heavy reliance on experience/intuition</li> </ul>
Test	4: Design and Implementation of Experiments	<ul> <li>Parameter inference experiment to maximize information gain in G<sub>h</sub> at V<sub>TEC</sub> = 4.0 V and T<sub>O-REx</sub> = -30 °C</li> <li>Full factorial model validation experiment with focus on bounding important parameters of domain of intended application of SXM</li> </ul>	System-level thermal balance test at worst hot case, cold case, and possibly a few intermediate cases
Model Update	5: Experimental Model Calibration and Flight Model Updates	<ul> <li>SXM thermal model parameters were <i>updated</i> (not replaced) via systematic, Bayesian calibration approach</li> <li>Remaining model inadequacy was quantified via Gaussian Process Models to predict inadequacy for any SXM power mode or spacecraft interface temperature</li> </ul>	<ul> <li>Manual correlation or parameter optimization model update procedure</li> <li>Differences between model predictions and experimental data are less than a threshold value (e.g., ±3 °C)</li> </ul>

For SXM case study, BMV led to additional information being available to the engineer at each major step of the validation process. BMV focused validation efforts to critical areas of SXM thermal system and provided a more rigorous quantification of model uncertainties before and after testing.

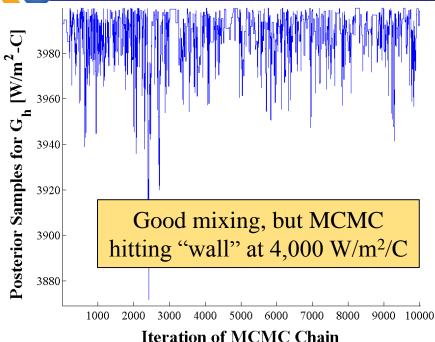
# Importance of T<sub>O-REx</sub> as System Design Parameter

- Cooling the SXM interface is driving thermal system accommodation for REXIS SXM
  - SXM is nominally facing the sun
  - Need to cool the SXM interface to 50 °C with the GEVS [17] standard thermal design margin of 5 °C
- Due to the 50 °C spacecraft interface upper limit, design changes to OSIRIS-REx included:
  - Heat spreader and RTV added to interface to decrease thermal resistance across interface
  - Changes in surface coatings near the SXM to help cool the mounting structure
  - Redesign of MLI blankets near the interface to increase heat rejection from structure to cooler parts of spacecraft
- Power cycling of REXIS *could* be necessary if temperatures are slightly warmer than expected
  - Operational mission plan has changed since the 50 °C upper limit was set
  - Power cycling introduces risk to spectrometer detector array that would require major rework to spectrometer electronics so that detectors could remain on if SXM were power cycled

The spacecraft-SXM interface temperature, T<sub>O-REx</sub>, is an important system design parameter. If the upper limit had been higher, some or all of the design changes and potential operational constraints would not have been necessary.



### **MCMC Results**



Increase upper bound of  $G_h$  distribution and update MCMC results

**Glasgow and Kittredge** [30]: Cho-Therm 1671 (applied to G<sub>h</sub> interface) tested near its vendor-specified value of 6,700 W/m<sup>2</sup>/C

Correlated posterior distributions:  $G_{s,b}$  and  $G_b$  affected by  $G_b$  "wall"

